In situ Imaging and Spectroscopy of the Carbon Deposition Mechanism on Ni/CeO₂ Solid Oxide Fuel Cell Anode Catalyst

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Ceria is a promising anode material for intermediate temperature (350-550°C) solid oxide fuel cells (SOFCs) due to its relatively high oxygen ion conductivity at these temperatures. Long-term stability of SOFCs may be limited by carbon deposition from the fuels onto the active anode (fuel oxidation) catalyst, causing deactivation or destruction of the ceramic-metal composite structure. Ceria has been shown to inhibit carbon deposition by quickly exchanging oxygen from its lattice to oxidize carbon on the surface of the electrode [1]. We are interested in understanding how ceria can affect carbon deposition at the gassolid interface by observing structural and chemical changes at the nanoscale. Environmental transmission electron microscopy (ETEM) provides the ability to observe nano-level structural changes under simulated reaction conditions which can be correlated with nanomaterials' performance through *in situ* and *operando* techniques [2]. *In situ* electron energy-loss spectroscopy (EELS) has also allowed dynamic changes in the local oxidation state of nanomaterials to be determined during catalysis [3]. A fundamental study of the local structural and chemical changes in a Ni/CeO₂ catalyst occurring under reaction conditions will provide information on the carbon deposition and may suggest mitigation strategies.

An FEI Titan ETEM was used to study gas-solid interactions of a model Ni/CeO₂ catalyst with two carbon source gases, ethane (C_2H_6) and ethylene (C_2H_4), to gain insight into carbon deposition processes relevant to SOFC applications. NiO was loaded onto CeO₂ cubes which were then reduced in situ in 1 Torr H₂ at 400°C. The hydrocarbon gas (C_2H_6 or C_2H_4) was introduced and samples were heated to 550°C. Figure 1 shows the structural changes that occurred during hydrocarbon exposure. When exposed to C₂H₄, carbon was deposited in the form of graphite layers whereas Ni surfaces remained free of graphite during C_2H_6 exposure. In situ EELS was used to monitor the valence state of $Ce^{3+/4+}$, which varies with the oxygen content of the ceria according to $Ce_x^{3+}Ce_{1-x}^{4+}O_{2-x/2}$. Ce valence can thus be used to interpret carbon deposition behaviors in terms of oxygen deficiency of the ceria support. Figure 2 a) and b) show highangular angle dark-field (HAADF) images where EELS lines scans were acquired in each source gas. Typical EELS spectra of the O K and Ce M₄₅ edges are shown as insets. The integrated intensity ratio of the M_4/M_5 peaks was used to correlate the EELS spectra to Ce valence. The table in Figure 2 c) indicates that no changes in local Ce valence states were observed during C_2H_4 exposure when compared to Ce valence state in H_2 . During C_2H_6 exposure under identical conditions, however, localized reduction zones were observed in the ceria support near Ni particles. Therefore, ceria inhibited carbon deposition during C_2H_6 exposure through localized oxygen exchange but was unable to do so during C_2H_4 exposure [4]. These results will be discussed in terms of a Mars van Krevelen carbon oxidation mechanism.

References:

[1] Wang, W., et al, Chemical Reviews, **113** (2013), p. 8104-8151.

[2] Tao, F. and P.A. Crozier, Chemical Reviews, **116** (2016), p. 3487-3539.

[3] Sharma, R., et al, Philosophical Magazine, 84 (2004), p. 2731-2747.

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Figure 1. a) & c) Ni/CeO₂ at 400°C in 4 Torr H₂ b) Ni/CeO₂ in 0.5 Torr C₂H₄ at 550°C with several graphite layers covering the Ni particle. d) Ni/CeO₂ in 1 Torr C₂H₆ at 550°C. The Ni particle surface remains clear of graphite and the crystalline ceria becomes amorphous.

	$\mathbf{O} \mathbf{K}$ Ce M ₄₅	b)		Ce Oxidation State			
a)			c)	Position	H ₂ 400°C	C ₂ H ₄ 550°C	C ₂ H ₆ 550°C
2	CeO2	000 000 001 000		1	3.95	3.74	3.98
1	1 2	CeO ₂ 4 Ni		2	3.95	3.78	3.79
	34 V	1		3	3.95	3.92	3.61
10 nm	Ni	10 nm		4	3.78	3.95	3.00

Figure 2. HAADF images of Ni/CeO₂ in a) 0.5 Torr C₂H₄ at 550°C and b) 1 Torr C₂H₆ at 550°C. Dotted lines indicate EELS line scan directions with position markers 1-4. The insets are typical EELS spectra of the O K and Ce M₄₅ edges near Ni particles. The table in c) shows the oxidation state of Ce along the line scans of a) and b) compared to a typical line scan in H₂. The highlighted values indicate that localized reduction zones of the ceria cube were observed near the Ni particle in C₂H₆ but no reduction zones were seen in C₂H₄.